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# **Overview:**

- 1.Arsenic and selenium are plagued by interferences when analyzed by ICP-MS.
- 2.<u>An awareness of these interferants is necessary to</u> produce defensible arsenic and selenium results.\*

"I analyze by ICP-MS. There are very few interferences associated with ICP-MS analyses."

"I analyze by KED/collision cell ICP-MS. I have eliminated the major interferences associated with As and Se analyses."

"You are barking up the wrong tree. Rare Earth Elements are called rare for a reason-they are rare."

**Recent Quotes from:** 

A lot of analysts and project leaders we try to tell this story to.

What could
possibly
interfere with
As and Se in
ICP-MS?
What doesn't
interfere with
As and Se in
ICD-MS?

Element	Mass	% Abundance	Dimer	Chlorides/ Hydrides
Arsenic	75	100		${}^{40}\text{Ar}{}^{35}\text{Cl}{}^{+}$ ${}^{40}\text{Ca}{}^{35}\text{Cl}{}^{+}$ ${}^{43}\text{Ca}{}^{16}\text{O}{}_{2}{}^{+}$ ${}^{23}\text{Na}{}^{12}\text{C}{}^{40}\text{Ar}{}^{+}$ ${}^{12}\text{C}{}^{31}\text{P}{}^{16}\text{O}{}_{2}{}^{+}$ ${}^{36}\text{Ar}{}^{39}\text{K}{}^{+}$
Selenium	77	7.63		<sup>40</sup> Ar <sup>37</sup> Cl <sup>+</sup> <sup>40</sup> Ca <sup>37</sup> Cl <sup>+</sup>
	78	23.77	<sup>38</sup> Ar <sup>40</sup> Ar <sup>+</sup> <sup>39</sup> K <sup>39</sup> K <sup>+</sup>	<sup>41</sup> K <sup>37</sup> Cl <sup>+</sup>
	80	49.61	<sup>40</sup> Ar <sup>40</sup> Ar <sup>+</sup> <sup>40</sup> Ca <sup>40</sup> Ca <sup>+</sup>	<sup>45</sup> Sc <sup>35</sup> Cl <sup>+</sup>
	82	8.73		<sup>45</sup> Sc <sup>37</sup> Cl <sup>+</sup> <sup>81</sup> BrH <sup>+</sup>

- 1. The <sup>81</sup>BrH<sup>+</sup> ion interferes with the determination of selenium at 82 amu.
- 2. If bromide is present in a sample, using the default equation for correcting the Cl interference on As will give positively biased results because of the <sup>81</sup>BrH+ interference at <sup>82</sup>Se.....The positive bias in arsenic results when using this equation in the presence of as little as 200 ug/L bromide will result in the arsenic concentration being 40% greater than is actually present.

Taken from <u>Methods of Analysis by the US Geological Survey National Water Quality Lab-Determination of Dissolved Arsenic, Boron,</u> <u>Lithium, Selenium, Strontium, Thallium, and Vanadium using Inductively Coupled Plasma-Mass Spectrometry</u> Open file report 99-093

## ICP-MS Normal Mode Default Interference Correction Equations for Arsenic and Selenium

```
<sup>82</sup>Se<sup>+</sup><sub>corr</sub>=<sup>82</sup>Se<sup>+</sup>-1.00869<sup>*83</sup>Kr<sup>+</sup>
```

ICP-MS Normal Mode Interference Correction Equations for Arsenic and Selenium when Bromine is Present in Matrix

```
^{75}As_{corr} = ^{75}As^{+} - 3.127*(^{40}Ar^{37}Cl^{+} - (0.322*^{78}Se^{+}))
```

```
<sup>82</sup>Se<sup>+</sup><sub>corr</sub>=<sup>82</sup>Se<sup>+</sup>-1.00869<sup>*83</sup>Kr<sup>+</sup>- (0.000468659<sup>*81</sup>Br<sup>+</sup>)
```

Internal Standard <sup>72</sup>Ge





Image 2







Image 5



Image 6



lmage 7





	<sup>81</sup> Br	<sup>75</sup> As Default Correction Equation	<sup>75</sup> As Correction Equation When Bromine is Present in Matrix	<sup>82</sup> Se Default Correction Equation	<sup>82</sup> Se Correction Equation When Bromine is Present in Matrix
	200 ppb	ND	ND	ND	ND
	1000 ppb	0.75 ppb	ND	2.4 ppb	ND
	10000 ppb	7.6 ppb	ND	26 ppb	ND
D	efault		Default		

<sup>75</sup>As<sub>corr</sub>=<sup>75</sup>As<sup>+</sup>-3.127\*(<sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup>-(0.874\*<sup>82</sup>Se<sup>+</sup>))

Default <sup>82</sup>Se<sup>+</sup><sub>corr</sub>=<sup>82</sup>Se<sup>+</sup>-1.00869<sup>\*83</sup>Kr<sup>+</sup>

Bromine in Matrix

Bromine in Matrix <sup>82</sup>Se<sup>+</sup><sub>corr</sub>=<sup>82</sup>Se<sup>+</sup>-1.00869<sup>\*83</sup>Kr<sup>+</sup>- (0.000468659<sup>\*81</sup>Br<sup>+</sup>)

<sup>75</sup>As<sub>corr</sub>=<sup>75</sup>As<sup>+</sup>-3.127\*(<sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup>-(0.322\*<sup>78</sup>Se<sup>+</sup>))

## Sample from a Thermal Bromination Process

<sup>81</sup> Br	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se
	Default	Correction	Default	Correction
	Correction	Equation	Correction	Equation
	Equation	When Bromine	Equation	When Bromine
		is Present in		is Present in
		Matrix		Matrix
320000 ppb	250 ppb	2.8 ppb	860 ppb	10 ppb

# Sample from a City Drinking Water Source

<sup>81</sup> Br	<sup>75</sup> As Default Correction Equation	<sup>75</sup> As Correction Equation When Bromine is Present in Matrix	<sup>82</sup> Se Default Correction Equation	<sup>82</sup> Se Correction Equation When Bromine is Present in Matrix
250 ppb	1.0 ppb	ND	1.2 ppb	ND

<sup>81</sup> Br	<sup>75</sup> As Default Correction Equation	<sup>75</sup> As Correction Equation When Bromine is Present in Matrix	<sup>75</sup> As KED Mode	Se Default Correction Equation	Se Correction Equation When Bromine is Present in Matrix	Se KED Mode
200 ppb	ND	ND	ND	ND	ND	ND
1000 ppb	0.75 ppb	ND	ND	2.4 ppb	ND	ND
10000 ppb	7.6 ppb	ND	ND	26 ppb	ND	ND

#### USEPA Method 200.8- Determination of Trace Elements in Waters and Wastes by Inductively Coupled Plasma-Mass Spectrometry Revision 5.5

<u>1.9</u> This method should be used by analysts experienced in the use of ICP-MS, the interpretation of spectral and matrix interferences and procedures for their correction.

2.2 Interferences relating to the techniques must be recognized and corrected for. Such corrections must include compensation for isobaric elemental interferences and interferences from polyatomic ions derived from the plasma gas, reagents or sample matrix.

<u>4.1.3</u>....Such interferences must be recognized, and when they cannot be avoided by the selection of alternative analytical isotopes, appropriate corrections must be made to the data. Equations for the correction of data should be established at the time of the analytical run sequence as the polyatomic ion interferences will be highly dependent on the sample matrix and chosen instrument conditions.

#### **Table 2:**

**Common Molecular Ion Interferences in ICP-MS** 

**Matrix Molecular Ions** 

Bromide <sup>81</sup>BrH<sup>+</sup> <sup>82</sup>Se

Table 5:

**Recommended Elemental Equations for Data Calculations** 

The arsenic correction calculation has a foot note:

1.Isobaric mass 82 must be from Se only and not BrH<sup>+</sup>.



# Data Review Request

Image10

Monitoring Well	Arsenic Method 6010 ICP	Arsenic Method 6020 ICP-MS Collision Cell	Arsenic Method 7062 Hydride	Arsenic Speciation	Arsenic Triple Quad
Sample 1 Total	28 ppb	15 ppb	ND	ND	ND
Sample 2 Total	190 ppb	<b>72 ppb</b>	ND	ND	ND

The method quality control results were all acceptable.



Lanthanum is a direct spectral overlap on arsenic at ICP-OES wavelength 189

PE ICP-OES 8300 USEPA Region 4 SESD ICS Brittany Stuart, Chemist

Element	Mass	% Abundance	Dimer	Chlorides/ Hydrides	Doubly Charged
Arsenic	75	100		${}^{40}\text{Ar}{}^{35}\text{Cl}{}^+$ ${}^{40}\text{Ca}{}^{35}\text{Cl}{}^+$ ${}^{43}\text{Ca}{}^{16}\text{O}_2{}^+$ ${}^{23}\text{Na}{}^{12}\text{C}{}^{40}\text{Ar}{}^+$ ${}^{12}\text{C}{}^{31}\text{P}{}^{16}\text{O}_2{}^+$ ${}^{36}\text{Ar}{}^{39}\text{K}{}^+$	<sup>150</sup> Sm <sup>++</sup> <sup>150</sup> Nd <sup>++</sup>
Selenium	77	7.63		<sup>40</sup> Ar <sup>37</sup> Cl <sup>+</sup> <sup>40</sup> Ca <sup>37</sup> Cl <sup>+</sup>	<sup>154</sup> Sm <sup>++</sup> <sup>154</sup> Gd <sup>++</sup>
	78	23.77	<sup>38</sup> Ar <sup>40</sup> Ar <sup>+</sup> <sup>39</sup> K <sup>39</sup> K <sup>+</sup>	<sup>41</sup> K <sup>37</sup> Cl <sup>+</sup>	<sup>156</sup> Gd <sup>++</sup> <sup>156</sup> Dy <sup>++</sup>
	80	49.61	<sup>40</sup> Ar <sup>40</sup> Ar <sup>+</sup> <sup>40</sup> Ca <sup>40</sup> Ca <sup>+</sup>	<sup>45</sup> Sc <sup>35</sup> Cl <sup>+</sup>	<sup>160</sup> Gd <sup>++</sup> <sup>160</sup> Dy <sup>++</sup>
	82	8.73		<sup>45</sup> Sc <sup>37</sup> Cl <sup>+</sup> <sup>81</sup> BrH <sup>+</sup>	<sup>164</sup> Dy <sup>++</sup> <sup>164</sup> Er <sup>++</sup>

## **Definition of Doubly Charged:**

If an ion is singly charged, its position in the mass spectrum corresponds to its mass. If an ion is doubly charged, it will appear in the spectrum at half its mass. At this mass it will interfere with isotopes of different elements. For Example: <sup>150</sup> Nd<sup>++</sup> on <sup>75</sup>As<sup>+</sup> or <sup>156</sup> Gd<sup>++</sup> on <sup>78</sup>Se<sup>+</sup>

# How Did We Miss This?

"Oxides (MO<sup>+</sup>) and doubly charged species (M2<sup>+</sup>) can be significantly reduced through proper tuning of the plasma and torch conditions and by good plasma design. <u>Oxides are far more problematic in ICP-MS</u> than doubly charged species since there are very few elements that generate significant levels of doubly charged species and these can be easily avoided.."

Taken from ICP-MS Inductively Coupled Plasma Mass Spectrometry A Primer from Agilent Technologies

Double charged ions are detected by the instrument as apparent isobars at half their actual mass.....There are no software corrections for this type of spectral interference, but optimization procedures used to set instrument operating conditions attempt to set double-charge formation to be a low fraction (less than 3 percent) of the single-charge ions present. Double-charge formation effects tend to be small or non existent when determining higher mass element concentrations, such as <sup>75</sup>As<sup>+</sup>. Natural abundance of double charged ions of the Lanthanide elements are low (Ryabchikov et al,. 1959).

Taken from "Arsenic and Thallium Data in Environmental Samples: Fact or Fiction?" Susan D. Chapnick, Leonard C. Pitts, Nancy C. Rothman Remediation Autumn 2010.

A doubly charged ion will cause a spectral interference at half the m/z of the singly charged ion, e.g. <sup>138</sup> Ba<sup>++</sup> on <sup>69</sup>Ga<sup>+</sup> or <sup>208</sup> Pb<sup>++</sup> on <sup>104</sup>Ru<sup>+</sup>. <u>These interferences are few</u> <u>and can be considerably minimized, or effectively</u> <u>eliminated, by optimizing the system before proceeding</u> <u>with the analysis.</u>

Taken from "ICP-MS, or ICP-AES and AAS?-a comparison Varian, ICP-MS-1 April 1994"

"Associated with oxide-based spectral overlaps are doubly charged spectral interferences. These are species that are formed when an ion is generated with a double positive charge, as opposed to a normal single charge, and produces a peak at half its mass. Like the formation of oxides, the level of doubly charged species is related to the ionization conditions in the plasma and can usually be minimized by careful optimization of the nebulizer gas flow, rf power, and sampling position within the plasma."

Taken from "A Beginner's Guide to ICP-MS, Part XII-A Review of Interferences Spectroscopy 17(10) October 2002"

# **Rare Earth Elements are Not Rare**





Image 12



Image 13



# Region 4 Rare Earth Element Deposits

Image 14

Taken from USGS publication-

"Unconventional Resources of Rare Elements:

The Bearing of Source and Process on the Genesis of Residual Deposits"



**Key Industrial Consumers and Products:** 

Automobile and petroleum industry

Glass industry, optics, high-quality lenses, crystal production, luminous fiber optics

High-performance electronics, high-tech weapons, satellite technology and telecommunications

Metallurgy, ceramics industry, and laser industry

Water treatment, alternative energies, marine biology

Paint and lacquer production, laboratories, drying technology, fluxing agents

Manufacture of magnets, batteries, spare parts industries Shieldings against radioactivity

Rare Earth Technology	Application(s)	REE required
Catalysts	•Oil production •Gasoline and hybrids, diesel fuel additive •Fluid cracking •Ethane polymerization	La, Ce, Pr, Nd, Lu, Y, Sm
Rare Earth permanent magnets and ceramic magnets	•Wind and hydro power generation •Cordless power tools •Generators •Hybrids, plug-in and electric vehicles •Electric assist motors •Medical imaging •Computer disc drives •Handheld wireless devices	Nd, Pr, Dy, Tb, Sm, Tm
Phosphors	•LCD TVs and monitors •Plasma TVs and displays •Energy efficient fluorescent lights & LEDs	Y, Eu, Tb, Gd, Ce, La, Dy, Pr, Sc
Energy storage	•NiMH batteries	La, Ce, Pr, Nd
Glass additives	•Fiber optics •Optical glass for digital camera	Ce, La, Nd, Er, Gd, Yb
Polishing powders	•LCD and Plasma TVs and monitors •Silicon wafers and chips	Ce, La, Pr
Others	•Lasers •Superconductors •Nuclear applications •Fertilizers •High tech alloys	•Yb, Y, Dy, Tb, Eu, Sm, Nd •Gd •Ce, Er •various REE •Yb, Lu, Er, Tb, Gd, Eu, Sm, Nd Pr, Ho, Sc

	Rare Earth	<sup>75</sup> As	<sup>78</sup> Se	
	Element	Uncorr	Uncorr	
	1000 ppb Eu	ND	ND	
Initial Look at Rare Earth Element	1000 ppb Nd	44	ND	
Interference on As	1000 ppb Sm	29	ND	
	1000 ppb Gd	ND	620	
	1000 ppb Dy	ND	1.5	
PE NexION 300D ICP-MS KED Mode	1000 ppb Pr	ND	-13	
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Linie waiton, Chemist				

# What can we do to minimize this problem?

It was suggested to minimize doubly charged by: Cooling Plasma Lowering Nebulizer Flow

Determine a correction by empirically measuring the signals and mathematically calculating the ratios.

#### NexION 300D

#### Sample ID: 500ppb Nd

Sample Date/Time: Tuesday, March 03, 2015 16:03:17 Method File: C:\NexIONData\Method\EPA NexION KED-FAST As Se.mth Dataset File: C:\NexIONData\DataSet\030315\500ppb Nd.017 Tuning File: c:\nexiondata\masscal\epa\_default.tun Optimization File: c:\nexiondata\conditions\epa\_default.dac

Sample Description: 1X

Sample File: C1NexIONData\Sample\022315.sam

Batch ID: 030315

Autosampler Position: 104

	AnalyteM	ass	Blank Intensity	Meas. Intensity	Intens, RSD	Conc. Mean	onc. SD	Conc. RSD
Г	Ge	72	64928.598	81836.450	1.8 %			%
1	Ge	74	99700.860	101268.135	1.9 %			%
>	In-1	115	379108.891	359212.670	4.1 %			%
1	As	75	3.667	5536.406	2.6 %	17.709864	1.1907	6.7 %
1	2010 As	75	3.659	31.005	295.1 %	0.095979	0.3032	315.9 %
	Se	76	23619.185	22786.841	3.5 %			%
1	Se	77	-3.716	-1.050	1.7 %			%
1	Se	78	37.333	30.333	8.3 %	-0.157345	0.0616	39.2 %
1	2070_Se	78	37.328	30.293	8.3 %	-0.158463	0.0615	38.8 %
1	Br	79	20.333	26.667	4.3 %			%
1	Se	82	3.667	6.000	44.1 %	0.152486	0.1554	101.9 %
1	Se-1	82	3.600	4.536	58.6 %	0.066976	0.1576	235.3 %
1	Br	81	37.000	36.333	4.2 %			%
1	Kr	83	6.333	6.333	36.5 %			%
1	Nd	146	1.667	1928143.675	1.3 %			%
L	Nd	143	3.000	1221979.124	2.2 %			%
1	Nd	145	1.000	900358.476	1.6 %			%
1	Sm	147	1.000	28.000	18.9 %			%
1	Sm	149	0.667	17.667	18.2 %			%
1	Eu	151	0.667	2.667	57.3 %			%
1	Eu	153	1.000	1.667	34.6 %			%
1	Gd	155	0.333	6.000	28.9 %			%
I.	Gd	157	1.333	9.667	15.8 %			%
1	Dy	161	6.667	4888.170	3.4 %			%
1	Dy	163	12.333	131.334	6.4 %			%
L	Er	166	11.333	3884.862	3.6 %			%
-		-						

PE NexION 300D ICP-MS

KED Mode

**USEPA Region 4 SESD ICS** 

**Ernie Walton, Chemist** 

#### As75/Nd146 = (5536.406-3.667) / (1928143.675-1.667)

= 5532.739 / 1928143.008

= 0.0028695

#### As75corr=As75uncorr-0.0028695\*Nd146

REE	<sup>75</sup> As Uncorr	<sup>75</sup> As Corr	<sup>78</sup> Se Uncorr
10 ppb Nd	0.37	ND	ND
100 ppb Nd	3.5	ND	ND
500 ppb Nd	18	ND	ND
1000 ppb Nd	33	ND	ND
500 ppb Nd	36	18	18
+20 ppb ICV	180% Recovery	90% Recovery	90% Recovery

PE NexION 300D ICP-MS

KED Mode

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REE	<sup>75</sup> As Uncorr	<sup>75</sup> As Corr	<sup>78</sup> Se Uncorr
10 ppb Sm	ND	ND	ND
100 ppb Sm	2.5	ND	ND
500 ppb Sm	12	ND	ND
1000 ppb Sm	24	1.1	ND
500 ppb Sm	31	19	18
+20 ppb ICV	155%	95%	90%
	Recovery	Recovery	Recovery

PE NexION 300D ICP-MS KED Mode USEPA Region 4 SESD ICS Ernie Walton, Chemist

<sup>75</sup> As Uncorr ND ND	75As Corr ND	<sup>78</sup> Se Uncorr 5.7	<sup>78</sup> Se Corr ND
Uncorr ND ND	Corr ND	Uncorr 5.7	Corr ND
ND ND	ND	5.7	ND
ND			
	ND	55	ND
ND	ND	280	5.1
ND	ND	570	6.9
20	20	310	18
100%	100%	1550%	90%
Recovery	Recovery	Recovery	Recovery
•	ND ND 20 100% Recovery	NDNDNDND2020100%100%RecoveryRecovery	ND         ND         280           ND         ND         570           20         20         310           100%         100%         1550%           Recovery         Recovery         Recovery

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	REE	<sup>75</sup> As	<sup>75</sup> As	<sup>78</sup> Se
		oncon		Oncon
	10 ppb Er	ND	ND	ND
	100 ppb Er	ND	ND	ND
	500 ppb Er	ND	ND	ND
	1000 ppb Er	ND	ND	ND
	500 ppb Fr	19	19	19
	+20 ppb ICV	95%	95%	95%
		5570	5570	5570
		кесоverу	Kecovery	Recovery
KED Mode				
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	REE	<sup>75</sup> As Uncorr	<sup>75</sup> As Corr	<sup>78</sup> Se Uncorr
	10 ppb Eu	ND	ND	ND
	<b>100 ppb Eu</b>	ND	ND	ND
	500 ppb Eu	ND	ND	ND
	1000 ppb Eu	ND	ND	ND
	500 ppb Eu	19	19	19
	+20 ppb ICV	95%	95%	95%
		Recovery	Recovery	Recovery
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	REE	<sup>75</sup> As Uncorr	<sup>75</sup> As Corr	<sup>78</sup> Se Uncorr	<sup>78</sup> Se Corr
	10 ppb Mixed REEs	0.62	ND	5.9	ND
	100 ppb Mixed REEs	6.2	ND	57	ND
PE NexION 300D ICP-MS	500 ppb Mixed REEs +20 ppb ICV	50 250 Recovery	21 105% Recovery	300 1500% Recovery	15 75% Recovery
KED Mode USEPA Region 4 SESD ICS Ernie Walton, Chemist					

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#### ICP-MS Normal Mode Default Interference Correction Equations for Arsenic and Selenium

 $^{75}As_{corr} = ^{75}As^{+}-3.127^{*}(^{40}Ar^{37}Cl^{+}-(0.874^{*82}Se^{+}))$  $^{75}As_{corr} = ^{75}As^{+}-3.127^{*}(^{40}Ar^{37}Cl^{+}-(0.322^{*78}Se^{+}))$  $^{82}Se_{corr}^{+} = ^{82}Se^{+}-1.00869^{*83}Kr^{+}-(0.000468659^{*81}Br^{+})$ Internal Standard  $^{72}Ge$ 

Mass 72	<sup>144</sup> Nd <sup>++</sup> , <sup>144</sup> Sm <sup>++</sup>
Mass 75	<sup>150</sup> Nd <sup>++</sup> , <sup>150</sup> Sm <sup>++</sup>
Mass 77	<sup>144</sup> Gd <sup>++</sup> , <sup>144</sup> Sm <sup>++</sup>
Mass 81	<sup>162</sup> Er <sup>++</sup> , <sup>162</sup> Dy <sup>++</sup>
Mass 82	<sup>164</sup> Er <sup>++</sup> , <sup>164</sup> Dy <sup>++</sup>
Mass 83	<sup>166</sup> Er <sup>++</sup>

REE	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se
	Uncorr	Corr	Uncorr	Corr
10 ppb Nd	ND	ND	ND	ND
100 ppb Nd	0.95	0.84	ND	ND
500 ppb Nd	4.6	4.0	ND	ND
1000 ppb Nd	9.2	8.1	ND	ND
500 ppb Nd	23	21	18	18
+20 ppb ICV	115%%	105%	90%	90%
	Recovery	Recovery	Recovery	Recovery
+20 ppb ICV	115%% Recovery	105% Recovery	g Recov	90% very
ION 300D ICP-MS	<sup>75</sup> As <sup>+</sup> corr=	<sup>75</sup> As <sup>+</sup> -3.127*( <sup>40</sup> /	Ar <sup>37</sup> Cl <sup>+</sup> -(0.874 <sup>*8</sup>	<sup>2</sup> Se <sup>+</sup> ))
Mode	<sup>82</sup> Se <sup>+</sup> =	<sup>82</sup> Se <sup>+</sup> -1.00869*8	<sup>3</sup> Kr <sup>+</sup> - (0.000468	659* <sup>81</sup> Br <sup>+</sup> )
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REE	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se
	Uncorr	Corr	Uncorr	Corr
10 ppb Sm	ND	ND	ND	ND
100 ppb Sm	0.59	-4.7	ND	ND
500 ppb Sm	3.0	-23	ND	ND
1000 ppb Sm	6.0	-46	ND	ND
500 ppb Sm +20 ppb ICV	22 112% Recovery	-6.1 Recovery	19.2 96% Recovery	19.2 96% Recovery

<sup>75</sup>As<sub>corr</sub>=<sup>75</sup>As<sup>+</sup>-3.127\*(<sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup>-(0.874\*<sup>82</sup>Se<sup>+</sup>))

PE NexION 300D ICP-MS Standard Mode USEPA Region 4 SESD ICS Ernie Walton, Chemist

<sup>82</sup>Se<sup>+</sup><sub>corr</sub>=<sup>82</sup>Se<sup>+</sup>-1.00869<sup>\*83</sup>Kr<sup>+</sup>- (0.000468659<sup>\*81</sup>Br<sup>+</sup>)

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	REE	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se
		Uncorr	Corr	Uncorr	Corr
	10 ppb Gd	ND	ND	ND	ND
	100 ppb Gd	ND	-0.35	ND	ND
	500 ppb Gd	ND	-1.7	ND	ND
	1000 ppb Gd	ND	-3.6	ND	ND
		20	a <b>-</b>	10	10
	500 ppb Gd	20	1/	19	19
	+20 ppb ICV	100%	85%	95%	95%
		Recovery	Recovery	Recovery	Recovery
	<sup>75</sup> As,	corr= <sup>75</sup> As <sup>+</sup> -3.12	7*( <sup>40</sup> Ar <sup>37</sup> Cl <sup>+</sup> -(0	).874* <sup>82</sup> Se <sup>+</sup> ))	
exION 300D ICP-MS					
Jard Niode A Region 4 SESD ICS	82Se	$=^{82}Se^{+}-1.00$	)869* <sup>83</sup> Kr <sup>+</sup> - (0.	000468659*81	Br <sup>+</sup> )
	50	corr CC 1.00			

Ernie Walton, Chemist

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REE	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se
	Uncorr	Corr	Uncorr	Corr
10 ppb Dy	ND	0.52	1.9	1.9
100 ppb Dy	ND	4.8	18	18
500 ppb Dy	ND	24	91	91
1000 ppb Dy	ND	48	180	180
500 ppb Dy	20	42	110	110
+20 ppb ICV	100%	210%	550%	550%
	Recovery	Recovery	Recovery	Recovery
PE NexION 300D ICP-MS Standard Mode	$^{75}As_{corr} = ^{75}As^{+} - 3.1$	.27*( <sup>40</sup> Ar <sup>37</sup> Cl+-(0.874	* <sup>82</sup> Se <sup>+</sup> ))	
USEPA Region 4 SESD ICS Ernie Walton, Chemist	5e <sub>corr</sub> - 5e -1.0	50803 KI - (0.0004		41

REE	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se
	Uncorr	Corr	Uncorr	Corr
10 ppb Er	ND	ND	ND	-1.9
100 ppb Er	ND	ND	0.891	-20
500 ppb Er	ND	1.2	4.7	-100
1000 ppb Er	ND	2.5	9.5	-200
500 ppb Er	20	20	24	-80
+20 ppb ICV	100%	100%	120%	
	Recovery	Recovery	Recovery	Recovery
PE NexION 300D ICP-MS				
Standard Mode ${}^{75}As_{corr} = {}^{75}As^+ - 3.127^* ({}^{40}Ar^{37}Cl^+ - (0.874^{*82}Se^+))$				
Ernie Walton, Chemist	<sup>82</sup> Se <sup>+</sup> <sub>corr</sub> = <sup>82</sup> Se <sup>+</sup>	-1.00869* <sup>83</sup> Kr <sup>+</sup> - (0.000	9468659* <sup>81</sup> Br <sup>+</sup> )	
				42

REE	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se
	Uncorr	Corr	Uncorr	Corr
10 ppb Eu	ND	ND	ND	ND
100 ppb Eu	ND	ND	ND	ND
500 ppb Eu	ND	ND	ND	ND
1000 ppb Eu	ND	ND	ND	ND
500 ppb Eu +20 ppb ICV	20 100%	18 90%	20.0 100%	20.0 100%
	Recovery	Recovery	Recovery	Recovery
	<sup>75</sup> As <sub>corr</sub> = <sup>75</sup> As	<sup>+</sup> -3.127*( <sup>40</sup> Ar <sup>37</sup> Cl <sup>-</sup>	+-(0.874* <sup>82</sup> Se+))	

820 + 83	$2c_{+} \pm 4$ 00000 $\pm 83 V_{+} \pm 10$ 0004 cocco $\pm 81 D_{+} \pm 1$
$2^{\circ} = 2^{\circ}$	5P <sup>+</sup> -1.00869 <sup>*03</sup> Kr <sup>+</sup> -10.000468659 <sup>*0+</sup> Br <sup>+</sup>
Corr	

PE NexION 300D ICP-MS Standard Mode USEPA Region 4 SESD ICS

Ernie Walton, Chemist

REE	<sup>75</sup> As	<sup>75</sup> As	<sup>82</sup> Se	<sup>82</sup> Se	
	Uncorr	Corr	Uncorr	Corr	
10 ppb Mixed REEs	ND	ND	1.9	ND	
100 ppb Mixed REEs	1.6	0.94	19	-1.2	
500 ppb Mixed REEs	7.7	4.4	94	-8.6	
500 ppb	26	22	113	10	
Mixed REEs	130%	110%	565%	50%	
+20 ppb ICV	Recovery	Recovery	Recovery	Recovery	
PE NexION 300D ICP-MS Standard Mode $7^5As_{corr} = 7^5As^+ - 3.127^* (4^0Ar^{37}Cl^+ - (0.874^{*82}Se^+))$					
${}^{82}Se^{+}_{corr} = {}^{82}Se^{+} - 1.00869 * {}^{83}Kr^{+} - (0.000468659 * {}^{81}Br^{+}) $					

REE Collision Cell	<sup>75</sup> As Uncorr	<sup>75</sup> As with correction	<sup>78</sup> S Uncor	E <sup>78</sup> Se with rr correction
Sample 4x dilution	3.8mg/kg	<u>1.8 mg/kg</u>	8.9 mg/kg	<u>2.4 mg/kg</u>
REE Standard Mode	<sup>75</sup> As Uncorr	<sup>75</sup> As with correction	<sup>82</sup> Se Uncorr	<sup>82</sup> Se with correction
Sample 4x dilution	8.9 mg/kg	<u>1.7 mg/kg</u>	3.6 mg/kg	<u>2.6 mg/kg</u>
Sample 4x dilution	8.9 mg/kg Collis	<u>1.7 mg/kg</u> ion Cell C Uncorr Dou	3.6 mg/kg Collision Cell Rare Earth Element bly Charged Corrected	2.6 mg/kg Standard Mode Corrected
Sample 4x dilution Arsenic	8.9 mg/kg Collis 3.8 mg/kg	<u>1.7 mg/kg</u> ion Cell C Uncorr Dou ; 1.8 m	3.6 mg/kg Collision Cell Rare Earth Element bly Charged Corrected	2.6 mg/kg Standard Mode Corrected

	Sample Matrix	
Al	15400 mg/kg	
Са	6500 mg/kg	
Fe	3700 mg/kg	
Mg	450 mg/kg	Soil Sample
Na	50 mg/kg	from a
S	5200 mg/kg	Military
La	38 mg/kg	Base
Nd	12 mg/kg	
Sm	2.5 mg/kg	
Gd	3.3 mg/kg	
Dy	2.3 mg/kg	
Er	1.0 mg/kg	
Cu	100 mg/kg	
Ва	270 mg/kg	
Pb	140 mg/kg	
Sr	1000 mg/kg	
Zn	90 mg/kg	45

# <sup>75</sup>As<sub>corr</sub> = <sup>75</sup>As<sup>+</sup> - 3.127 \* (<sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup> - (0.874 \* <sup>82</sup>Se<sup>+</sup>))

### Mass Possible Interferences

- <sup>75</sup>As<sup>+</sup> <sup>40</sup>Ar<sup>35</sup>Cl<sup>+</sup>, <sup>150</sup>Dy<sup>++</sup>, <sup>150</sup>Sm<sup>++</sup>
- <sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup> <sup>77</sup>Se<sup>+</sup>, <sup>154</sup>Gd<sup>++</sup>, <sup>154</sup>Sm<sup>++</sup>
- <sup>82</sup>Se<sup>+</sup> <sup>82</sup>Kr<sup>+</sup>, <sup>164</sup>Er<sup>++</sup>, <sup>164</sup>Dy<sup>++</sup>, <sup>81</sup>Br<sup>1</sup>H<sup>+</sup>

# <sup>75</sup>As<sub>corr</sub> = <sup>75</sup>As<sup>+</sup> - 3.127 \* (<sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup> - (0.874 \* <sup>82</sup>Se<sup>+</sup>))

 ${}^{75}\text{As}_{corr} = {}^{75}\text{As}^{+} - 3.1005 * (({}^{40}\text{Ar}{}^{37}\text{Cl}^{+} - 0.00457 * {}^{147}\text{Sm}147^{+} - 0.000326 * {}^{157}\text{Gd}^{+}) \\ - (0.874 * ({}^{82}\text{Se}^{+} - 0.00293 * {}^{163}\text{Dy}^{+}))) - 0.00177 * {}^{146}\text{Nd}^{+} - 0.00144 * {}^{147}\text{Sm}^{+}$ 

# <sup>82</sup>Se<sup>+</sup><sub>corr</sub>=<sup>82</sup>Se<sup>+</sup> - 1.0087 \* <sup>83</sup>Kr<sup>+</sup> - (0.00046866 \* <sup>81</sup>Br<sup>+</sup>)

## Mass Possible Interferences

- <sup>82</sup>Se<sup>+</sup> <sup>82</sup>Kr<sup>+</sup>, <sup>81</sup>Br<sup>1</sup>H<sup>+</sup>, <sup>164</sup>Er<sup>++</sup>, <sup>164</sup>Dy<sup>++</sup>
- <sup>83</sup>Kr<sup>+</sup> <sup>166</sup>Er<sup>++</sup>
- <sup>81</sup>Br<sup>+</sup> <sup>162</sup>Er<sup>++</sup>, <sup>162</sup>Dy<sup>++</sup>

<sup>82</sup>Se<sup>+</sup><sub>corr</sub> = <sup>82</sup>Se<sup>+</sup> - 1.0087 \* <sup>83</sup>Kr<sup>+</sup> - (0.00046866 \* <sup>81</sup>Br<sup>+</sup>)

 ${}^{82}Se^{+}_{corr} = {}^{82}Se^{+} - (1.0087 * ({}^{83}Kr^{+} - 0.00248 * {}^{166}Er^{+})) - (0.000469 * ({}^{81}Br^{+} - 0.00236 * {}^{163}Dy^{+})) - (0.00293 * {}^{163}Dy^{+}) - (0.000109 * {}^{166}Er^{+})$ 

### An alternate calculation for As if elevated Br is present.

<sup>75</sup>As<sub>corr</sub> = <sup>75</sup>As<sup>+</sup> - 3.127 \* (<sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup> - (0.322 \* <sup>78</sup>Se<sup>+</sup>))

## Mass Possible Interferences

- <sup>75</sup>As<sup>+</sup> <sup>40</sup>Ar<sup>35</sup>Cl<sup>+</sup>, <sup>150</sup>Dy<sup>++</sup>, <sup>150</sup>Sm<sup>++</sup>
- <sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup> <sup>77</sup>Se<sup>+</sup>, <sup>154</sup>Gd<sup>++</sup>, <sup>154</sup>Sm<sup>++</sup>
- <sup>78</sup>Se<sup>+</sup> <sup>38</sup>Ar<sup>40</sup>Ar<sup>+</sup>, <sup>156</sup>Gd<sup>++</sup>, <sup>156</sup>Dy<sup>++</sup>

<sup>75</sup>As<sub>corr</sub> = <sup>75</sup>As<sup>+</sup> - 3.127 \* (<sup>40</sup>Ar<sup>37</sup>Cl<sup>+</sup> - (0.322 \* <sup>78</sup>Se<sup>+</sup>))

 $^{75}As_{corr} = ^{75}As^{+} - 3.1005 * ((^{40}Ar^{37}Cl^{+} - 0.00457 * ^{147}Sm^{+} - 0.000326 * ^{157}Gd^{+}) - (0.322 * (^{78}Se^{+} - 0.00307 * ^{157}Gd^{+}))) - 0.00177 * ^{146}Nd^{+} - 0.00144 * ^{147}Sm^{+}$ 

**Ocean Dredging Dump Sites** Land Fills **Battery Dump Sites Plating Sites** Mills **Transformer Sites Chemical Sites Mountain Top Mining** Sites **Pesticide Sites Phosphate Mines Military Bases Fertilizer Sites Urban Background** 



Image 19

mage 20 52

### **Conclusions:**

Arsenic and selenium are subject to interferences from bromine and Rare Earth Element doubly charged formation when analyzed by ICP-MS. It is not unusual to find the presence of bromine or REEs in environmental samples.

The analytical community should be informed of this challenge that could lead to false positive/high bias results or false negative/low bias results for As and Se.

## **Procedures USEPA Region4 SESD/ASB/ICS has initiated to address this challenge:**

- -Monitoring all samples for bromine and Rare Earth Elements in the sample matrix
- -Attempting to create correction factors that will consistently work with collision cell ICP-MS and Standard Mode ICP-MS
- -Working /talking with Perkin Elmer, Agilent, LTIG, and other EPA analysts to address this problem
- -Beginning to look at ½ mass corrections
- -Talking with project managers to let them know what we are doing and what they should be asking for from ICP-MS/ICP analyses

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#### **Images**

- 1. Image no source found
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